

# Agilent 4339B/4349B High Resistance Meters

**Technical Overview** 

# Within Budget Without Compromise

#### Introducing the Agilent Technologies 4339B and 4349B High Resistance Meters Used for Making Ultra-High Resistance Measurements

For precision bench-top applications, the 1-channel 4339B is the premier solution for accurate high resistance and low current tests. For high resistance testing in manufacturing environments, the 4349B offers simultaneous 4-channel high resistance measurements for increased test throughput.



#### Satisfy Your Needs for ...

#### **High quality results**

- High confidence testing with contact check function
- Remove parasitics with error correction
- Consistent data with 0.6% basic accuracy
- Compensation for handler contact chattering with trigger delay

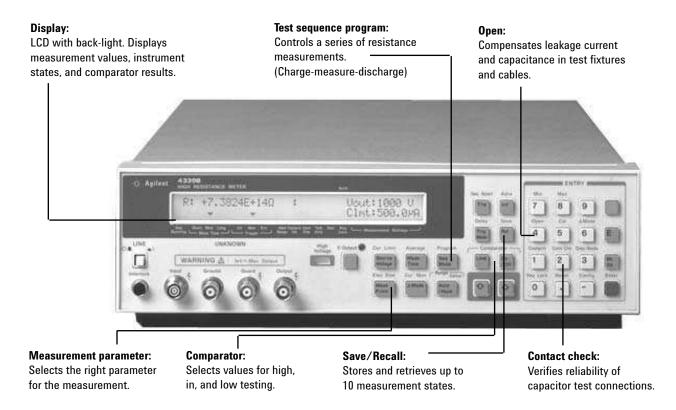
#### Versatile measurements

- Select from four test parameters
- Use a variety of test fixtures and accessories
- Perform a charge-measuredischarge sequence with the test sequence program function
- Save and recall up to ten measurement setups

#### High test throughput: 4349B

- 9.5 ms measurements
- 4-channels for multiple DUTs
- 4-channel simultaneous testing
- Fast contact checking: 2 ms/ measurement
- GPIB and handler interfaces
- Ideal for high volume capacitor testing







Agilent 4349B 4-channel high resistance meter

#### **Key parameters and specifications**

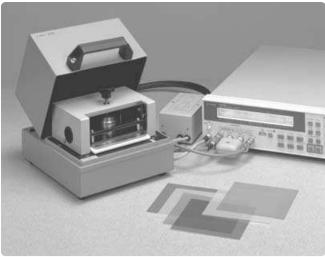
	Agilent 4339B	Agilent 4349B
Test channels	1	2ch, Option 4349B-001
		4ch, Option 4349B-700
Test voltage(Vdc)	0.1 to 1000	Requires external power source <sup>1</sup>
Measurement parameters	R, I, pv, ps	R, I
Measurement range $(\Omega)$	10 <sup>3</sup> to 1.6x10 <sup>16</sup>	10 <sup>3</sup> to 10 <sup>15</sup>
Basic accuracy	0.6%	2%
Display resolution	3 / 4 / 5 digits	3 / 4 / 5 digits
Measurement time	10 ms/30 ms/390 ms	9.5 ms/28 ms/98 ms/397 ms

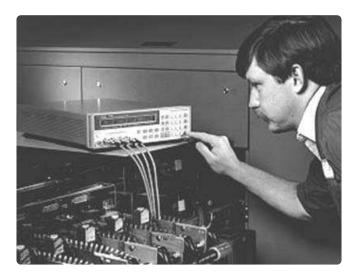
External power source required for resistance measurements. Recommendation for external power source for measurement for 1 GΩ sample at 100 Vdc with accuracy = ±10%:

Ripple:  $\leq 1 \text{ mVrms } (50/60 \text{ Hz})$ 

Wideband noise:  $\leq$  5 µVrms/Hz (50 Hz) Switching noise:  $\leq$  50 mVrms (100 kHz)







# High quality measurements with flexible hardware

- Resolve data to 5 digits (3, 4, or 5 digits selectable)
- Make precise measurements with 0.6% basic accuracy
- Verify DUT performance at the exact voltage rating
- Reliable and safety measurements with Agilent 16339A component test fixture

# 4339B solutions for high voltage material testing

- Resistivity mathematics built-in: surface and volume
- Agilent 16008B resistivity cell for solid samples
- Easy measurements with test sequence program function (controls charge-measuredischarge sequence)
- Customize your fixture cabling with the Agilent 16117C test leads

# System features you need to be successful

- Maximize accuracy with error correction
- Test capacitor contact failure with contact check function
- Automate testing with GPIB interface
- Reduce ground-loops with isolated handler interface
- Pass/Fail testing with comparator function (high/in/low)

#### Capacitor evaluation with the 4349B

- Optimize capacitor Vdc rating tests
- Increase throughput four times with 4-channels
- Improve reliability with contact check
- Get low noise results with Agilent 16117E test lead

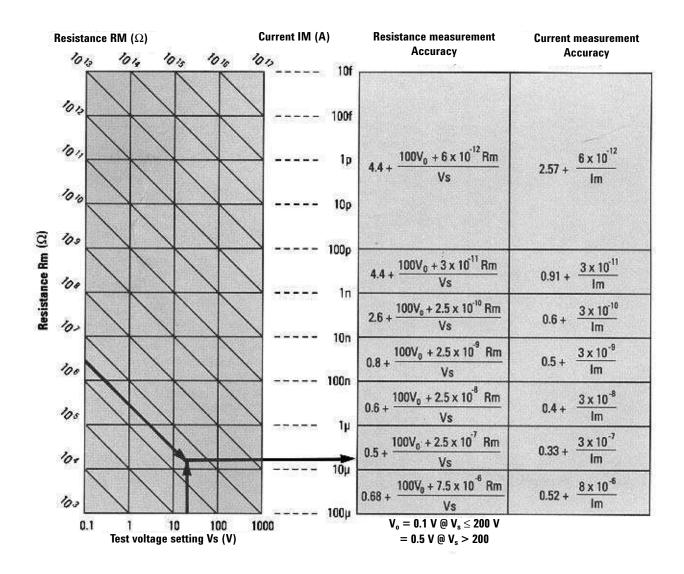


Figure 1. Conversion diagram

#### Table 1. Agilent 4339B measurement accuracy ( $\pm\%$ of reading)

# Specifications Measurement Accuracy

#### Agilent 4339B test conditions\*:

- 1. Warm up time:  $\geq 30$  minutes
- 2. Ambient temperature: 23 °C  $\pm$  5 °C
- 3. Test cable length:  $\leq 1.5$  meters
- 4. Open error correction performed
- 5. Long measurement time setting
- 6. Contact check: off

#### **Accuracy parameters:**

Rm: Measured resistance value in W Im: Measured current value in amperes

Vs: Source voltage in volts

Vo:  $0.1 \text{ V@Vs} \le 200 \text{ V}, 0.5 \text{ V@Vs} > 200 \text{ V}$ 

#### **Accuracy example:**

To determine the accuracy of a measurement use Figure 1, "Conversion diagram".

For example: determine the accuracy of a 5 M $\Omega$  (= 5 x  $10^{\rm e}\Omega$ ) measurement at 50 Vdc.

 $Rm = 5 \times 10^6 \Omega$ Vs = 50 V lel to the  $10^{\rm s}\,\Omega$  diagonal line intersects the vertical Vs line at the second row from the bottom of the diagram. Moving horizontally across to Table 1, the following equation is found:

The intersection of Rm running paral-

$$0.5 + \frac{100 \text{ Vo} + (2.5 \times 10^{7} \times Rm)}{Vs}$$

Entering the values for Rm, Vo, and Vs yields an accuracy of ±0.725%.

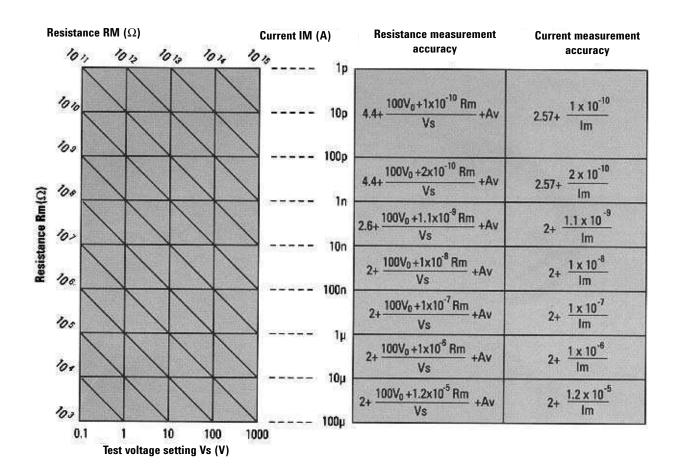


Figure 2. Conversion diagram

Table 2. Agilent 4349B measurement accuracy ( $\pm\%$  of reading)

#### Agilent 4349B test conditions1:

- 1. Warm up time:  $\geq 30$  minutes
- 2. Ambient temperature: 23 °C  $\pm$  5 °C
- 3. Test cable length:  $\leq 1.5$  meters
- 4. Open error correction performed
- 5. 30 ms measurement time setting

#### **Accuracy parameters:**

 $\it Rm$ : Measured resistance value in ohms

Im: Measured current value in

amperes

#### **External power supply parameters:**

Vs: Source voltage in volts

Vo: Source offset voltage in Volts

Av: Voltage accuracy

Other test condition data available in the operation manual.

### **Other Specifications**

Measurement parameters/ranges	
Parameter Agilent 4339B	Range
Ayrient 4555b	
R (dc resistance)	$10^3~\Omega$ to $1.6~\mathrm{x}$ $10^{16}~\Omega$
I (dc current)	60 fA to 100 μA
ps (surface resistivity)	Refer to operation manual
pv (volume resistivity)	Refer to operation manual
Agilent 4349B	
R (dc resistance)	10 $^3$ $\Omega$ to 10 $^{15}$ $\Omega$
I (dc current)	1 pA to 100 μA

#### Measurement conditions and functions

DC test voltage (4339B): 0 V to  $1000 \text{ V}, 0.1 \text{ V steps } @ \text{V} \le 200 \text{V}, 1.0 \text{ V}$ steps @ V > 200 V DC test voltage (Agilent 4349B): None supplied, use external power supplies and voltage data entry for resistance measurements. Maximum of 5000 V input and 5 digit numerical entry. Max current (Agilent 4339B):  $10 \text{ mA } @ \le 100 \text{ V}, 5 \text{ mA } @ \le 250 \text{ V}, 2$  $mA @ \le 500 \text{ V}, 1 mA @ \le 1 \text{ kV}$ Number of test channels: 4339B: 1 channel, 4349B: Option 4349B-700:4 ch Option 4349B-001:2 ch Ranging: Auto and hold Trigger: Internal, manual, and external Delay time (trigger): 0 ms to 9999 ms in 1 ms steps Test cable lengths: 2 meters

maximum Measurement time (typical): 4339B: 10 ms / 30 ms / 390 ms4349B: 9.5 ms / 28 ms / 98 ms /

397 ms

#### Other instrument functions

Error correction: Open (removes errors due to parasitics). Comparator: High, in, and low for each of the test parameters. Save/Recall: 10 instrument states from non-volatile memory. Contact check: Detects contact failure for capacitive devices (2 ms). GPIB: Agilent's implementation of IEEE 488 for control and data. Handler interface: Negative logic and isolated. Signals are high/in/low, no contact, EOM, index, alarm, keylock, ext. trigger.

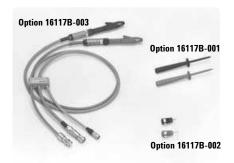
#### Physical characteristics

Power: 90 - 132 Vac or 198 - 264 Vac. 47 Hz - 66 Hz. 45 VA (typical) Operating temperature/humidity: 0 - 45 °C/≤ 95% RH @ 40 °C. Dimensions: 320(W) x 100(H) x 450(D) mm. Weight: 6.5 kg (typical).

#### **Test Fixtures/Accessories**



**Agilent 16339A component test fixture**For manual high voltage testing of discrete components. For 4339B only.



#### Agilent 16117B low noise test leads

Wide jaw clip leads for 4339B. 1 meter cable. Applicable measurement range:  $\leq 1 \times 10^{11} \Omega$  (typical). For 4339B only. Option 16117B-001 adds a pair of pin-type probes. Option 16117B-002 adds a pair of socket adapters for connecting to a custom made fixture. Option 16117B-003 adds a pair of alligator clips.



#### Agilent 16117C low noise test leads

Interlock, voltage source, and current sensing cables. Terminations are threaded triaxial, standard BNC, and bare interlock pair. Female BNC and triaxial connectors are included. For 4339B only.



Agilent 16118A tweezer test fixture

Tweezer test fixture for easy testing for chip components. Maximum applied voltage: 100 Vdc. Applicable measurement range:  $\leq 1 \times 10^{11} \Omega$  (typical). For 4339B only.



#### Agilent 16008B resistivity cell

For resistivity measurements of dry sheet samples. Upper electrode is spring loaded to apply pressure. Surface and volume measurements. Installed with 50 mm diameter electrode. Option 16008B-001 adds 26 mm/76 mm diameter electrodes. Option 16008B-002 adds 26 mm diameter electrode. For 4339B only. Maximum applied voltage: 1000 Vdc. Sheet thickness range: 10 µm to 100 mm.



Agilent 16117E low noise test lead Male-triaxial to male-triaxial connectors. One meter cable. One female-triaxial connector included. For 4349B only.

#### **Ordering Information**

- O = Choose ONE and ONLY one
- ☐ = Choose any combination

#### Agilent 4339B High Resistance Meter

Furnished accessories: shunt connector

#### Documentation options<sup>2</sup>

☐ Option 4339B-ABA	Add specified quantities of English manual
☐ Option 4339B-ABJ	Add specified quantities of Japanese manual
□ Option 4339B-0BW	Add service documentation, assembly level

#### Certification option

☐ Option 4339B-1A7 ISO 17025 compliant calibration

#### Agilent 4339B test fixtures and accessories

Agilent 16008B	Resistivity cell (50 mm diameter electrode)
☐ Option 16008B-001	Add 26 mm and 76 mm diameter electrodes
□ Option 16008B-002	Add 26 mm diameter electrode

Agilent 16117B	Low noise test leads
☐ Option 16117B-001	Add pin probes
☐ Option 16117B-002	Add soldering sockets
☐ Option 16117B-003	Add alligator clips <sup>3</sup>

Agilent 16117C	Low noise test leads
Agilent 16118A	Tweezer test fixture
Agilent 16339A	Component test fixture

#### Agilent 4349B High Resistance Meter4

#### Test channel options<sup>5</sup>

O Option 4349B-700	4-channels
O Option 4349B-001	2-channels

# Agilent 4349B high resistance meter<sup>6</sup> Documentation options

-	
☐ Option 4349B-ABA	Add specified quantities of English manual
☐ Option 4349B-ABJ	Add specified quantities of Japanese manual
☐ Option 4349B-0BW	Add service documentation, assembly level

#### Cabinet options7

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☐ Option 4349B-1CM	Rack mount kit
☐ Option 4349B-1CN	Front handle kit

#### Certification option

Option 4349B-1A7 ISO 17025 compliant calibration

#### **Agilent 4349B Test Fixtures and Accessories**

Agilent 16117E Low noise test lead

#### Web Resource

www.agilent.com/find/lcmeters

Agilent Email Updates
www.agilent.com/find/emailupdates

Get the latest information on the products and applications you select.

- Test fixture is not furnished with the 4339B.
- Manual is not furnished with the 4339B.
- 3. The alligator clips are not furnished as standard.
- External power source required for resistance measurements.
- 5. 2-channels to 4-channels upgrade not available.
- Manual is not furnished as standard.
- Rack flange and handle kit are not compatible.

### Agilent Direct

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